Search Notes

Applic	ation/Control No.	Applicant(s)/Patent u Reexamination	nder
10/622	2,038	TAKAMURA, TAKAS	SHI
Exami	ner	Art Unit	
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SEARCHED					
Class	Subclass	Date	Examiner		
438	613-617	4/25/2005	DLN		
	132				
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438	108				
257	778				
	529				
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	737				
257	738	4/25/2005	DLN		
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
438	613	4/26/2005	DLN			
438	108	4/26/2005	DLN			

SEARCH NO (INCLUDING SEARCH)
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East Search (USPAT,USPGPUB,EPO,JPO, DERWENT).	4/25/2005	DLN
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